

Search Notes  	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/810,889	TANINO ET AL.
	Examiner	Art Unit
	Quang T. Van	3742

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
219	619	12/12/05	QJ
399	69	12/12/05	QJ